

MOSFET - Power, Single N-Channel, STD Gate, SO8FL

80 V, 2.6 mΩ, 154 A NTMFS3D0N08X

Features

- Low Q_{RR}, Soft Recovery Body Diode
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Synchronous Rectification (SR) in DC-DC and AC-DC
- Primary Switch in Isolated DC-DC Converter
- Motor Drives

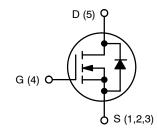
MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter		Symbol	Value	Unit
Drain-to-Source Voltage		V_{DSS}	80	V
Gate-to-Source Voltage		V_{GS}	±20	V
Continuous Drain Current	T _C = 25°C	I _D	154	Α
(Note 1)	T _C = 100°C		109	
Power Dissipation (Note 1)	T _C = 25°C	P_{D}	133	W
Pulsed Drain Current	T _C = 25°C,	I _{DM}	634	Α
Pulsed Source Current (Body Diode)	t _p = 100 μs	I _{SM}	634	
Operating Junction and Storage Temperature Range		T _J , T _{STG}	-55 to +175	°C
Source Current (Body Diode)		Is	201	Α
Single Pulse Avalanche Energy (I _{PK} = 53 A) (Note 3)		E _{AS}	140	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T _L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Actual continuous current will be limited by thermal & electromechanical application board design.
- 3. E $_{AS}$ of 140 mJ is based on started T $_J$ = 25°C, I $_{AS}$ = 53 A, V $_{DD}$ = 64 V, V $_{GS}$ = 10 V, 100% avalanche tested

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
80 V	2.6 m Ω @ 10 V	154 A



N-CHANNEL MOSFET

MARKING DIAGRAM



DFN5 (SO-8FL) CASE 488AA



3D0N08 = Specific Device Code

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS3D0N08XT1G	DFN5 (Pb-Free)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case		1.12	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	39	

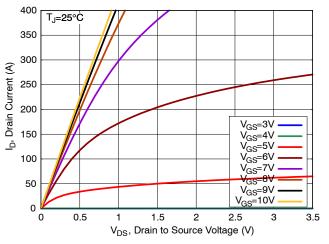
- 4. Surface-mounted on FR4 board using 1 in² pad, 1 oz. Cu.
- 5. $R_{\theta JA}$ is determined by the user's board design.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		ı			
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1 mA	80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$\Delta V_{(BR)DSS}/$ ΔT_J	I _D = 1 mA. Referenced to 25°C		31.6		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V, T _J = 25°C			1	μΑ
		V _{DS} = 80 V, T _J = 125°C			250	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 20 V, V _{DS} = 0 V			100	nA
ON CHARACTERISTICS						
Drain-to-Source On Resistance	e On Resistance $R_{DS(on)}$ $V_{GS} = 10 \text{ V}, I_D = 37 \text{ A}$	V _{GS} = 10 V, I _D = 37 A		2.2	2.6	mΩ
		V _{GS} = 6 V, I _D = 18 A		3.3	5.2	1
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 184 \mu A$	2.4		3.6	V
Gate Threshold Voltage Temperature Coefficient	ΔV _{GS(TH)} / ΔT _J	$V_{GS} = V_{DS}, I_D = 184 \mu A$		-7.5		mV/°C
Forward Transconductance	9FS	V _{DS} = 5 V, I _D = 37 A		115		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE					
Input Capacitance	C _{ISS}			3200		pF
Output Capacitance	Coss	, , , , , , , , , , , , , , , , , , ,		930		
Reverse Transfer Capacitance	C _{RSS}	$V_{GS} = 0 \text{ V}, V_{DS} = 40 \text{ V}, f = 1 \text{ MHz}$		14		
Output Charge	Q _{OSS}			66		nC
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 6 V, V _{DD} = 40 V, I _D = 37 A		28		1
				45]
Threshold Gate Charge	Q _{G(TH)}			10		
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 10 \text{ V}, V_{DD} = 40 \text{ V}, I_D = 37 \text{ A}$		15		
Gate-to-Drain Charge	Q_{GD}			7		
Gate Plateau Voltage	V_{GP}			4.7		V
Gate Resistance	R_{G}	f = 1 MHz		0.8		Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(ON)}			24		ns
Rise Time	t _r	Resistive Load,		8]
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 0/10 \text{ V}, V_{DD} = 40 \text{ V}, \\ I_{D} = 37 \text{ A}, R_{G} = 2.5 \Omega$		35]
Fall Time	t _f	1		6		
SOURCE-TO-DRAIN DIODE CHARACTE	ERISTICS					
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V}, I_S = 37 \text{ A}, T_J = 25^{\circ}\text{C}$		0.82	1.2	V
		V _{GS} = 0 V, I _S = 37 A, T _J = 125°C		0.66		<u></u>
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dl/dt = 1000 A/μs,		23		ns
Charge Time	t _a			13]
Discharge Time	t _b	$I_S = 37 \text{ A}, V_{DD} = 40 \text{ V}$		11]
Reverse Recovery Charge	Q _{RR}	7		163		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

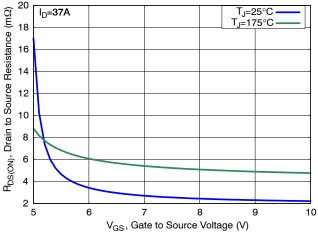
TYPICAL CHARACTERISTICS



400 V_{DS}=5V 350 300 Drain Current (A) 250 T_{J=}-55°C-T_J=25°C-200 T_J=175°C 150 ئ 100 50 0 0 8 V_{GS}, Gate to Source Voltage (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



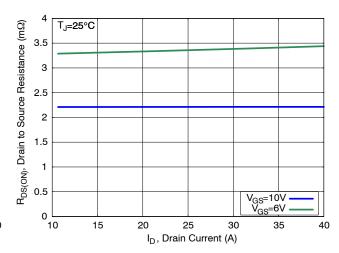
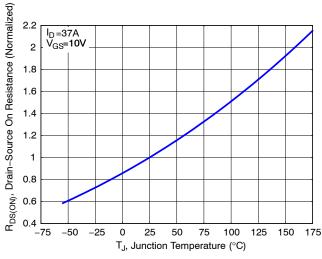


Figure 3. On-Resistance vs. Gate Voltage

Figure 4. On-Resistance vs. Drain Current



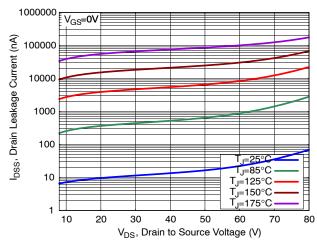


Figure 5. Normalized ON Resistance vs. Junction Temperature

Figure 6. Drain Leakage Current vs. Drain Voltage

TYPICAL CHARACTERISTICS

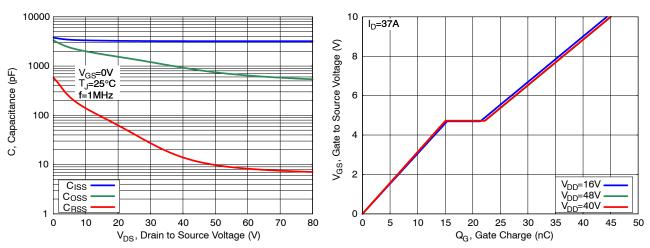


Figure 7. Capacitance Characteristics

Figure 8. Gate Charge Characteristics

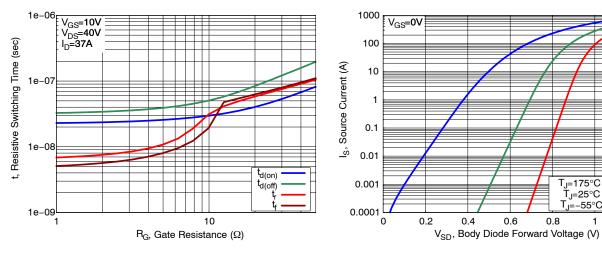


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Characteristics

1.2

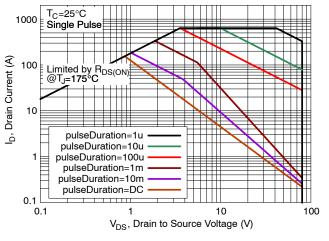


Figure 11. Safe Operating Area (SOA)

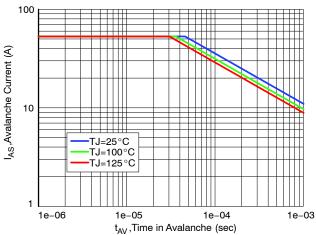


Figure 12. Avalanche Current vs. Pulse Time (UIS)

TYPICAL CHARACTERISTICS

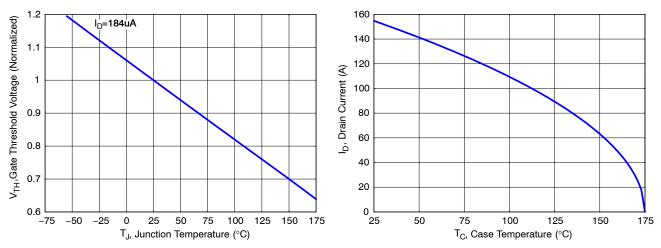


Figure 13. Gate Threshold Voltage vs. Junction Temperature

Figure 14. Maximum Current vs. Case Temperature

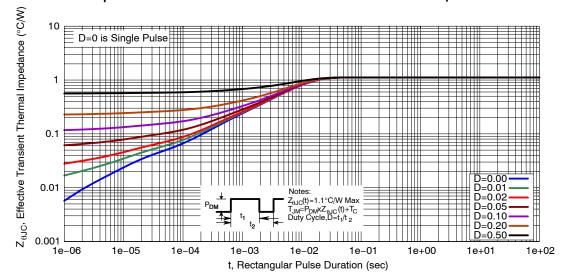
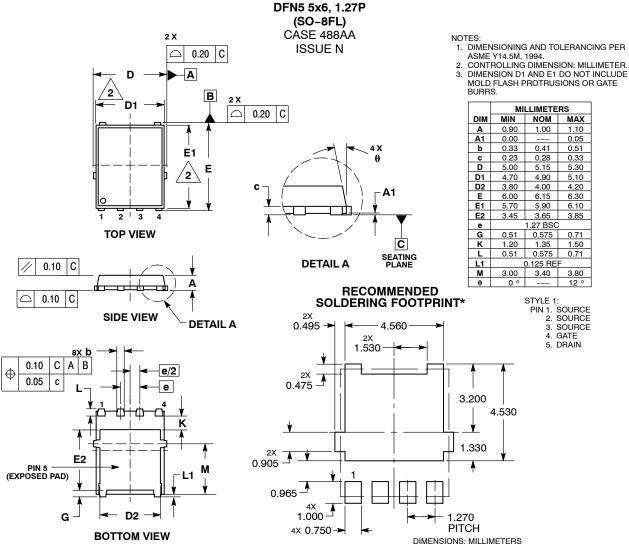


Figure 15. Transient Thermal Response

PACKAGE DIMENSIONS



*For additional information on our Pb-Free strategy and soldering details, please download the **onsemi** Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized tor use as a critical component in life support systems or any EDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Sho

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at www.onsemi.com/support/sales

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for ON Semiconductor manufacturer:

Other Similar products are found below:

041950FB 0W888-002-XTP 100307QCX 12A02CH-TL-E 15025-512-XTD 15C01C-TB-E 15C01M-TL-E 15C01SS-TL-E 15C02CH-TL-E 15C02MH-TL-E 15GN03CA-TB-E 15GN03MA-TL-E 1.5KE120ARL4 1.5KE18ARL4G 1.5KE250A 1.5KE27ARL4G 1.5KE39ARL4G 1.5KE47ARL4G 1.5SMC20AT3 1.5SMC24AT3 1.5SMC27AT3 1.5SMC39AT3 1.5SMC47AT3 1.5SMC68AT3 1.5SMC82AT3 1HN04CH-TL-W 1HP04CH-TL-W 1N3064 1N3070TR 1N3595 1N3595TR 1N4001G 1N4001RLG 1N4002G 1N4002RLG 1N4003G 1N4003RLG 1N4004RLG 1N4004RLG 1N4005G 1N4005RLG 1N4005TR 1N4005TR 1N4006FFG 1N4006G 1N4006RLG 1N4007FFG 1N4007G 1N4007RLG 1N4148 1N4148_T26A